Product data sheet

1. Product profile

1.1 General description

NPN silicon microwave transistor for high speed, low noise applications in a plastic, 4-pin dual-emitter SOT343F package.

1.2 Features and benefits

- Low noise high linearity microwave transistor
- High output third-order intercept point 34 dBm at 1.8 GHz
- 40 GHz f_T silicon technology

1.3 Applications

- Ka band oscillators DRO's
- C-band high output buffer amplifier
- ZigBee
- LTE, cellular, UMTS

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	-	16	٧
V_{CEO}	collector-emitter voltage	open base	-	-	5.5	٧
V_{EBO}	emitter-base voltage	open collector	-	-	2.5	٧
I _C	collector current		-	70	100	mA
P _{tot}	total power dissipation	$T_{sp} \le 85 ^{\circ}C$	-	-	490	mW
h _{FE}	DC current gain	$I_C = 20 \text{ mA}; V_{CE} = 2 \text{ V}; T_j = 25 ^{\circ}\text{C}$	90	135	180	
C _{CBS}	collector-base capacitance	V _{CB} = 2 V; f = 1 MHz	-	404	-	fF
f _T	transition frequency	$I_C = 60 \text{ mA}; V_{CE} = 1 \text{ V}; f = 2 \text{ GHz};$ $T_{amb} = 25 \text{ °C}$	-	18	-	GHz
G _{p(max)}	maximum power gain	$I_C = 60 \text{ mA}; V_{CE} = 1 \text{ V}; f = 1.8 \text{ GHz};$ $T_{amb} = 25 \text{ °C}$	-	20.5	-	dB
NF	noise figure	I_C = 15 mA; V_{CE} = 2 V; f = 1.8 GHz; Γ_S = Γ_{opt}	-	0.65	-	dB
P _{L(1dB)}	output power at 1 dB gain compression	$\begin{split} I_C &= 70 \text{ mA}; \ V_{CE} = 4 \text{ V}; \ Z_S = Z_L = 50 \ \Omega; \\ f &= 1.8 \text{ GHz}; \ T_{amb} = 25 \ ^{\circ}\text{C} \end{split}$	-	22	-	dBm

^[1] T_{sp} is the temperature at the solder point of the emitter lead.

 $[\]label{eq:Gpmax} \mbox{[2]} \quad \mbox{$G_{p(max)}$ is the maximum power gain, if $K > 1$. If $K < 1$ then $G_{p(max)}$ = Maximum Stable Gain (MSG).}$



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2. Pinning information

Table 2. Discrete pinning

Pin	Description	Simplified outline	Graphic symbol
1	emitter		
2	base	3 4	4
3	emitter		2 —
4	collector		'`)
			1, 3
		2 1	mbb159

3. Ordering information

Table 3. Ordering information

Type number	ype number Package		
	Name	Description	Version
BFU690F	-	plastic surface-mounted flat pack package; reverse pinning; 4 leads	SOT343F

4. Marking

Table 4. Marking

Type number	Marking	Description
BFU690F	D4*	* = p : made in Hong Kong
		* = t : made in Malaysia
		* = w : made in China

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	16	V
V_{CEO}	collector-emitter voltage	open base	-	5.5	V
V_{EBO}	emitter-base voltage	open collector	-	2.5	V
I _C	collector current		-	100	mA
P _{tot}	total power dissipation	$T_{sp} \le 85 ^{\circ}C$ [1]	-	490	mW
T _{stg}	storage temperature		-65	+150	°C
T_j	junction temperature		-	150	°C

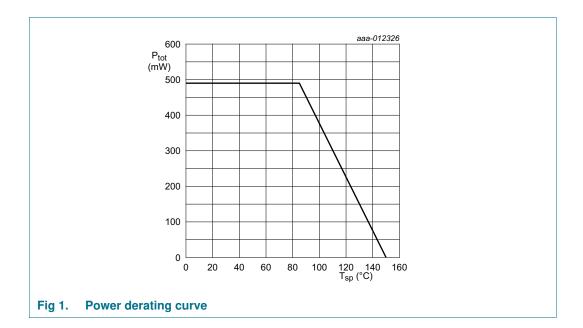
^[1] T_{sp} is the temperature at the solder point of the emitter lead.

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	<u>[1]</u>	132	K/W

[1] Determined by simulation.



NPN wideband silicon RF transistor

7. Characteristics

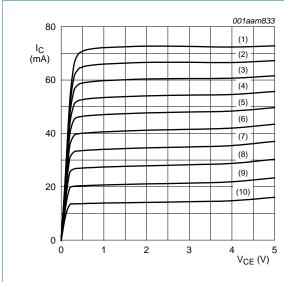
Table 7. Characteristics

 $T_j = 25$ °C unless otherwise specified

mbol	Parameter	Conditions	Min	Тур	Max	Unit
BR)CBO	collector-base breakdown voltage	$I_C = 2.5 \mu A; I_E = 0 \text{ mA}$	16	-	-	٧
BR)CEO	collector-emitter breakdown voltage	I _C = 1 mA; I _B = 0 mA	5.5	-	-	٧
	collector current		-	70	100	mA
0	collector-base cut-off current	I _E = 0 mA; V _{CB} = 8 V	-	-	100	nA
.	DC current gain	I _C = 20 mA; V _{CE} = 2 V	90	135	180	
ES	collector-emitter capacitance	V _{CB} = 2 V; f = 1 MHz	-	527	-	fF
BS	emitter-base capacitance	V _{EB} = 0.5 V; f = 1 MHz	-	1699	-	fF
BS	collector-base capacitance	V _{CB} = 2 V; f = 1 MHz	-	404	-	fF
	transition frequency	I_C = 60 mA; V_{CE} = 1 V; f = 2 GHz; T_{amb} = 25 °C	-	18	-	GHz
(max)	maximum power gain	$I_C = 60 \text{ mA}; V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ °C}$ [1]				
		f = 1.5 GHz	-	22	-	dB
		f = 1.8 GHz	-	20.5	-	dB
		f = 2.4 GHz	-	17	-	dB
1 2	insertion power gain	$I_C = 60 \text{ mA}; V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ °C}$				
		f = 1.5 GHz	-	15	-	dB
		f = 1.8 GHz	-	13.5	-	dB
		f = 2.4 GHz	-	11	-	dB
	noise figure	I_C = 15 mA; V_{CE} = 2 V; Γ_S = Γ_{opt} ; Γ_{amb} = 25 °C				
		f = 1.5 GHz	-	0.60	-	dB
		f = 1.8 GHz	-	0.65	-	dB
		f = 2.4 GHz	-	0.70	-	dB
ss	associated gain	I_C = 15 mA; V_{CE} = 2 V; Γ_S = Γ_{opt} ; T_{amb} = 25 °C				
		f = 1.5 GHz	-	18.5	-	dB
		f = 1.8 GHz	-	17.5	-	dB
		f = 2.4 GHz	-	15.5	-	dB
(1dB)	output power at 1 dB gain compression	I_C = 70 mA; V_{CE} = 4 V; Z_S = Z_L = 50 Ω ; T_{amb} = 25 °C				
		f = 1.5 GHz	-	22	-	dBm
		f = 1.8 GHz	-	22	-	dBm
		f = 2.4 GHz	-	20	-	dBm
3	third-order intercept point	I_C = 70 mA; V_{CE} = 4 V; Z_S = Z_L = 50 Ω ; T_{amb} = 25 °C				
		f = 1.5 GHz	-	34	-	dBm
		f = 1.8 GHz	-	34	-	dBm
		f = 2.4 GHz	-	33	-	dBm
3	third-order intercept point	$f = 2.4 \text{ GHz}$ $I_C = 70 \text{ mA; } V_{CE} = 4 \text{ V; } Z_S = Z_L = 50 \Omega;$ $T_{amb} = 25 \text{ °C}$ $f = 1.5 \text{ GHz}$ $f = 1.8 \text{ GHz}$	- - - -	20 34 34	- - - -	

^[1] $G_{p(max)}$ is the maximum power gain, if K > 1. If K < 1 then $G_{p(max)} = MSG$.

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 $T_{amb} = 25 \, ^{\circ}C.$

(1) $I_B = 550 \mu A$

(2) $I_B = 500 \mu A$

(3) $I_B = 450 \mu A$

(4) $I_B = 400 \mu A$

(5) $I_B = 350 \mu A$

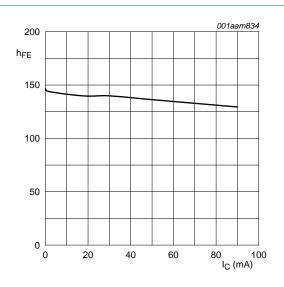
(6) $I_B = 300 \mu A$

(7) $I_B = 250 \mu A$

(8) $I_B = 200 \mu A$

(9) $I_B = 150 \mu A$ (10) $I_B = 100 \mu A$

Fig 2. Collector current as a function of collector-emitter voltage; typical values



 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \,^{\circ}\text{C}.$

Fig 3. DC current gain as a function of collector current; typical values

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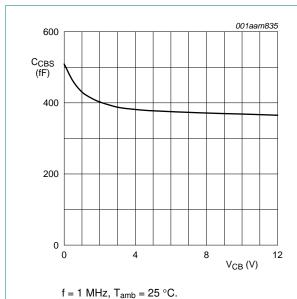
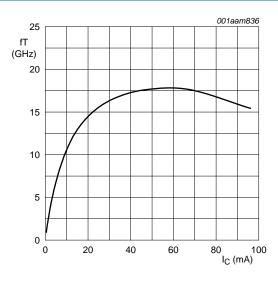
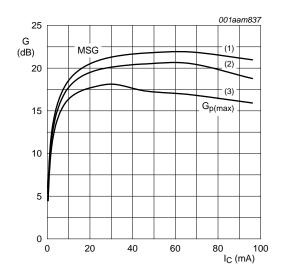


Fig 4. Collector-base capacitance as a function of collector-base voltage; typical values



 $V_{CE} = 1 \text{ V}$; f = 2 GHz; $T_{amb} = 25 \, ^{\circ}\text{C}$.

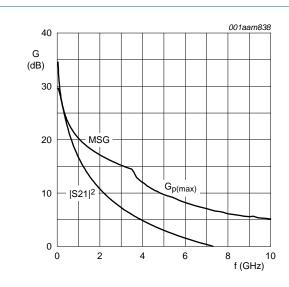
Fig 5. Transition frequency as a function of collector current; typical values



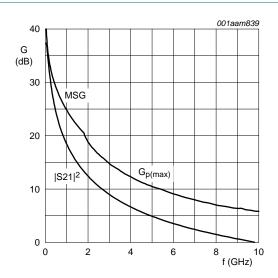
 $V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ }^{\circ}\text{C}.$

- (1) f = 1.5 GHz
- (2) f = 1.8 GHz
- (3) f = 2.4 GHz

Fig 6. Gain as a function of collector current; typical value



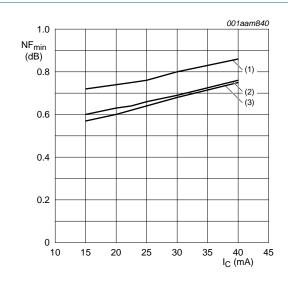
 V_{CE} = 1 V; I_{C} = 10 mA; T_{amb} = 25 °C.



 $V_{CE} = 1 \text{ V}$; $I_{C} = 60 \text{ mA}$; $T_{amb} = 25 \,^{\circ}\text{C}$.

Fig 7. Gain as a function of frequency; typical values

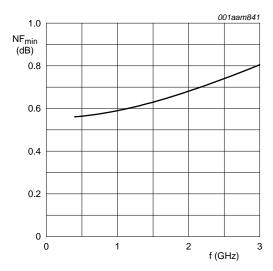




 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \text{ }^{\circ}\text{C}.$

- (1) f = 2.4 GHz
- (2) f = 1.8 GHz
- (3) f = 1.5 GHz

Fig 9. Minimum noise figure as a function of collector current; typical values



$$V_{CE} = 2 \text{ V}; I_{C} = 15 \text{ mA}; T_{amb} = 25 \text{ °C}.$$

Fig 10. Minimum noise figure as a function of frequency; typical values

Package outline

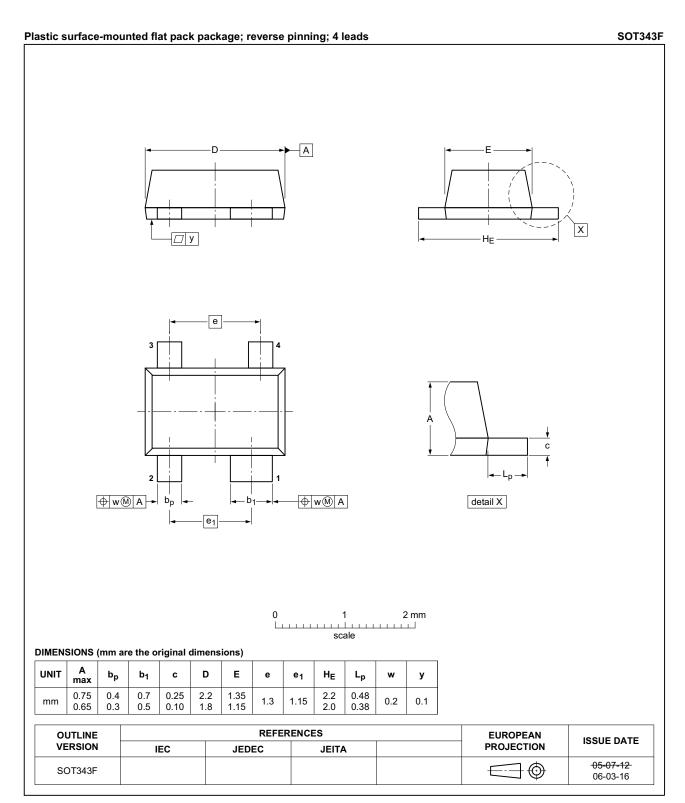


Fig 11. Package outline SOT343F

Product data sheet

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9. Handling information

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

10. Abbreviations

Table 8. Abbreviations

Acronym	Description
DRO	Dielectric Resonator Oscillator
Ka	Kurtz above
LTE	Long Term Evolution
NPN	Negative-Positive-Negative
UMTS	Universal Mobile Telecommunications System

11. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BFU690F v.2	20140314	Product data sheet	-	BFU690F v.1
Modifications:	Table 1 on pa	age 1: The value and conditions for Ptot have been updated.		updated.
	Table 5 on pa	ge 2: The value and conditions	s for P _{tot} have been u	updated.
	 <u>Table 6 on page 3</u>: The value and conditions for R_{th(j-sp)} have been updated. 			en updated.
	Figure 1 on page	age 3: The graph has been up	dated.	
	• Section 9 on page 9: The ESD caution has been moved here from Section 1.1 on page 1.			
BFU690F v.1	20101216	Product data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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